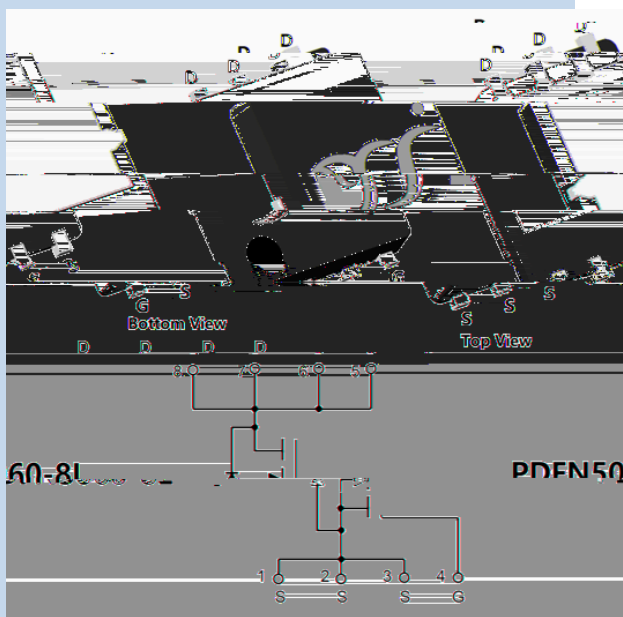


;\$;\$(\$(<FE'

a Ybh' AcXY' :]Y'X' 9ZZYWh' HfUbg]ghcf''



DfcXiWh'Gi a aUfm'

V_{DS}	40V
I_D	300A
$R_{DS(ON)}$ (at $V_{GS}=10V$)	0.85m
100% EAS Tested	
100% V_{DS} Tested	

; YbYfU' 8YgWf]dh]cb'

Split gate trench MOSFET technology
Excellent package for heat dissipation
High density cell design for low $R_{DS(ON)}$

Absolute Maximum Ratings (A25 un

	Gma Vc''	@]a]h'	I b]h'
	V_{DS}	40	V
	V_{GS}	±20	V
	I_D	43	A
		30	
		300	
		212	
	EAS	1458	mJ
	P_D	3	W
		1.5	
		136	
		68	
	T_J, T_{STG}	-55 +175	

DF9: 9F98'D#B'	D57?-B ; 7C89'	Auf_]b['	A=B-A I A' D57?5 ; 9fidWgk'	-BB9F'6CL' E I 5BH=HMfidWgk'	C I H9F'75FHCB' E I 5BH=HMfidWgk'	89@-J9FM' AC89'
YJG300G04HRQ	F1	G300G04HR	5000	10000	100000	13" reel

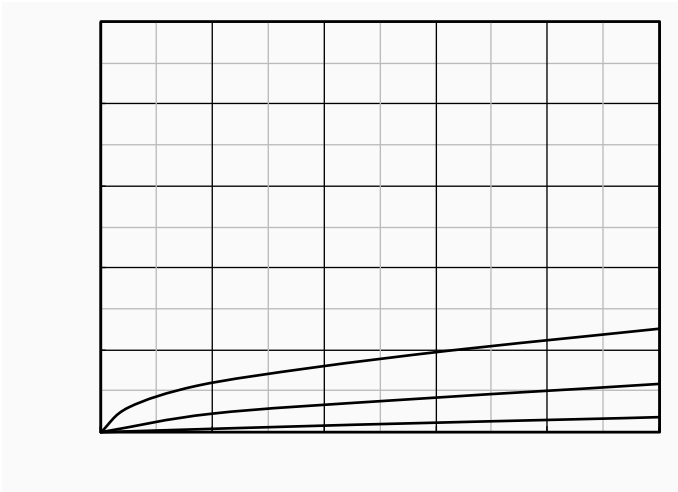


9`YWhf]WU`7 \UfUWhYf]gh]Wg'(T_J=25 unless otherwise noted)

DUfU a YhYf'	Gma Vc''	7cbX]h]cbg'	A]b'
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Hmd]WU`9`YWhf]WU`UbX`H\Yf a U`7\UfUWhYf]gh]Wg'8]U[fU ag`



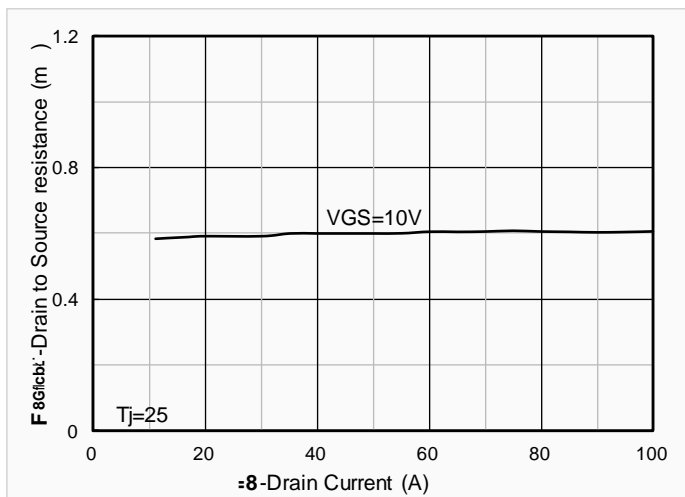


Figure 7. RDS(on) VS Drain Current

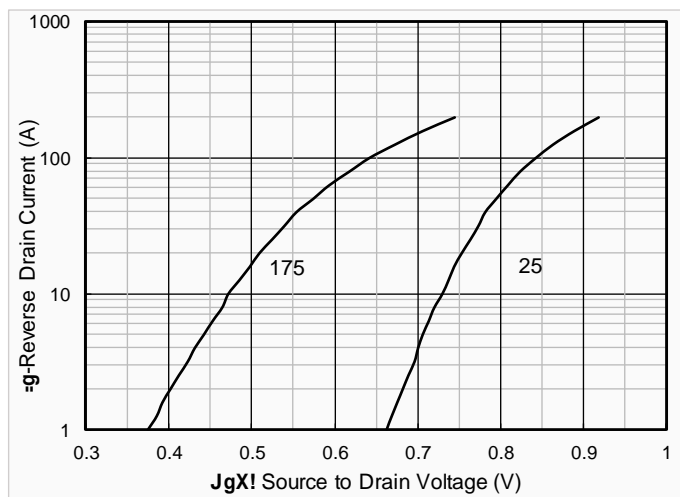


Figure 8. Forward characteristics of reverse diode

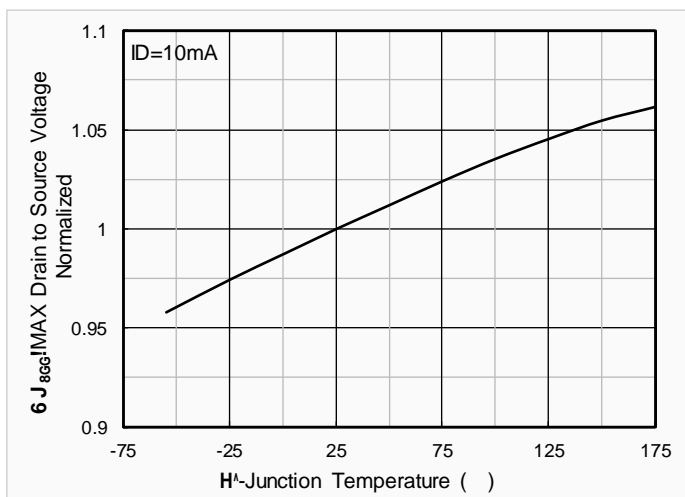


Figure 9. Normalized breakdown voltage

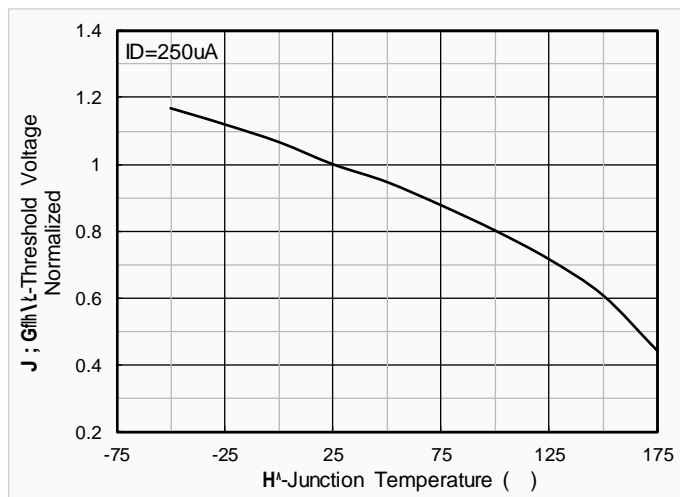
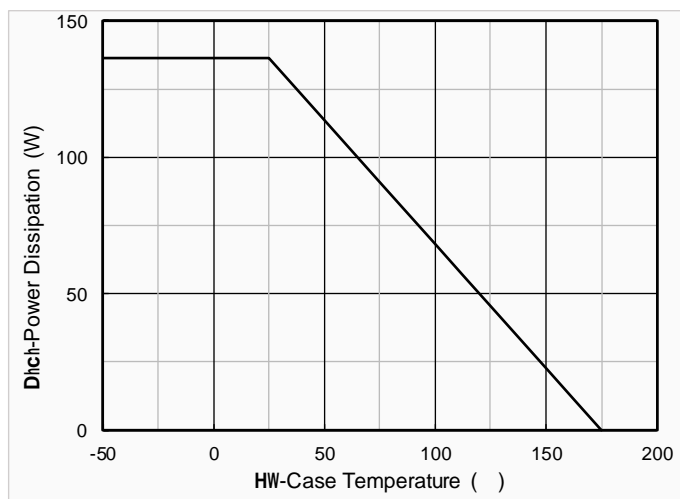
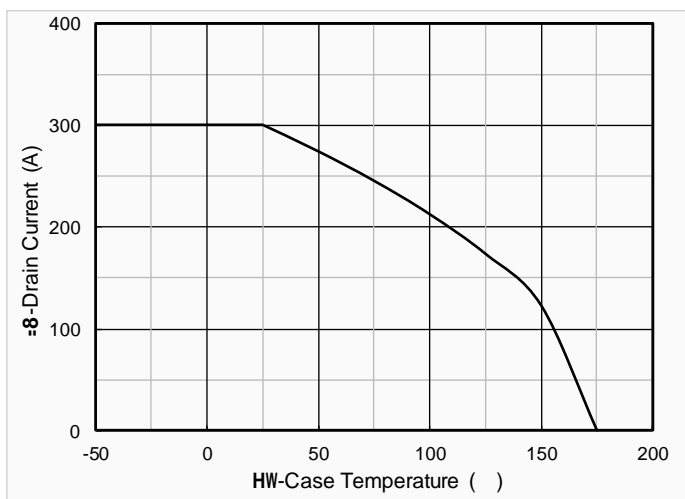
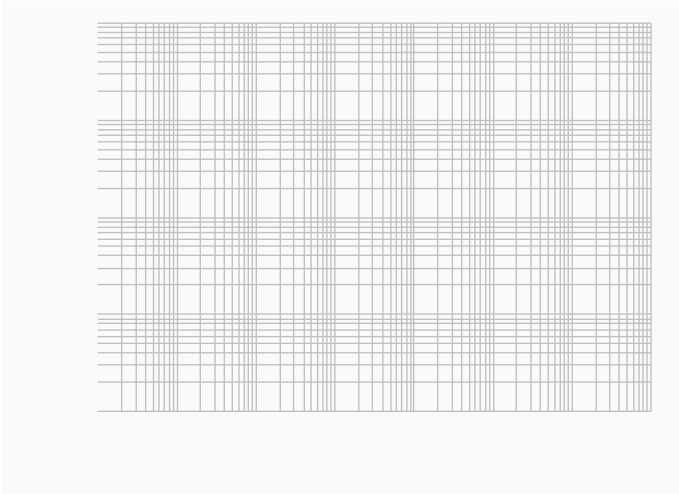


Figure 10. Normalized Threshold voltage





M> ; '\$\$; \$(< FE'



'LVFODLPHU

7KH LQIRUPDWLRQ SUHVHQWHG LQ WKLV <DQJ> KRXVH QDQV MIRHU (WHIHFWURQ HFRQRQFH QRO
ULJKW WR PDNH FKDQJH RU ZWLVK RXSWHQR SAURVGLFQV RIGWVSOD\HG KHUHLQ WRGLHPSLWRY
RWKHU ZLVH

7KH SURGXFW OLVWJHGH HWIRILEQLXW BSHZLWKF WXURRERW DYRUQRWHGLQV P JHGH FDO OLIH
VDYLQJ OLIHVXVWD <DQJ> R UODQD QH R QXPMV ERKU DLSREQOLELQRW \DQJGQPDUH
VXFK LPSURSHU XVH RI VDOH

7KLV SXEOLF DWLRQ SXOSSHUW DGDVL QURJPDVXLSRQLSHGHYRUR XDGGLRQLRSDOD VQRHJLWWRSX
ZZZ \DQJMLHRFRPRQVXOW \RXUH QH DDFHW R DQJMKW DDFH